Search Notes

Application/Control No.	Applicant(s)/Pate Reexamination	ent under	
10/814,572	MITCHELL ET A	۸L.	
Examiner	Art Unit		
HABTE MERED	2474		

SEARCHED				
Class	Subclass	Date	Examiner	
370	218	12/18/2010	НМ	
370	219	12/18/2010	НМ	
370	230	12/18/2010	НМ	
370	217	12/18/2010	НМ	
370	220	12/18/2010	НМ	
370	216	12/18/2010	НМ	
370	225-228	12/18/2010	НМ	
370	245	12/18/2010	НМ	
714	4,40	12/18/2010	НМ	
709	201	12/18/2010	НМ	
709	245	12/18/2010	НМ	
709	225	12/18/2010	НМ	
709	231	12/18/2010	НМ	
709	239	12/18/2010	НМ	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Limited text Search in EAST DB:USPAT, USPG-PUB, JPO, and EPO	12/18/2010	НМ		
Searched Palm Inventor's DB	5/20/2009	НМ		
Searached IEEE	5/20/2009	НМ		
Limited text search of all classes/sub- classes listed above	12/18/2010	НМ		
Limited text search of all classes/sub- classes listed above	7/3/2011	НМ		
Text Searached IEEE and EAST (ALL DBs)	7/3/2011	НМ		